



International Journal of Current Microbiology and Applied Sciences (IJCMAS)

ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online)

An International, Monthly, Online, Free Access, Peer Reviewed, Indexed, Scientific Research Journal

CERTIFICATE OF PUBLICATION

This is to certify that the following article reviewed by editorial board and published in

International Journal of Current Microbiology and Applied Sciences (IJCMAS) ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online).

Int.J.Curr.Microbiol.App.Sci.2018.7.(7):937-945

<https://doi.org/10.20546/ijcmas.2018.707.113>

Studies on Correlation and Path Analysis for Spot Blotch Disease Resistance and Yield Parameters in F2 Segregating Population of Durum Wheat (*Triticum durum* L.)

C.K. Chethana¹, V. Rudranaik^{1*}, S.A. Desai², S.S. Biradar¹, Y. Narendra Kadoo³, I.K. Kalappanavar⁴ and B.N. Aravindkumar⁵

1AICRP on Wheat, Main Agricultural Research Station, University of Agricultural Sciences Dharwad - 580 005, Karnataka, India

2Protection of Plant Varieties and Farmer's Right Authority (PPV & FRA), PUSA, NewDelhi-110012, India)

3Biochemical Sciences Division, CSIR-National Chemical Laboratory, Pune, Maharashtra, India

4Department of Plant Pathology

5Department of Agronomy, University of Agricultural Sciences Dharwad - 580 005, Karnataka, India

Dr. M.Prakash

Editor-in-chief

International Journal of Current Microbiology and Applied Sciences

www.ijcmas.com

www.excellentpublishers.com

